

Notice of References Cited	Application/Control No. 10/046,926	Applicant(s)/Patent Under Reexamination TEIG ET AL.	
	Examiner Vuthe Siek	Art Unit 2825	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,415,422 B1	07-2002	Mehrotra et al.	716/5
	C	US-6,557,145 B2	04-2003	Boyle et al.	716/2
	D	US-6,480,991 B1	11-2002	Cho et al.	716/8
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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